



Pending

Active

- ✖ L12: (16089) (wordline or word-line or (word adj line)) near5 decod\$4
- ✖ L13: (404981) latch\$4
- ✖ L14: (689216) invert\$4
- ✖ L16: (983) 12 with 13
- ✖ L16: (59) 14 with 15
- ✖ L22: (2162) 12 same 13
- ✖ L23: (250) 14 same 22
- ✖ L24: (191) 23 not 16
- ✖ L26: (5106) 365/230.06
- ✖ L26: (2713) 365/230.08
- ✖ L27: (3300) 365/189.09
- ✖ L28: (2234) 365/189.11
- ✖ L29: (349) 326/105
- ✖ L30: (262) 326/108
- ✖ L32: (9) 22 and 30
- ✖ L34: (19) 22 and 29
- ✖ L33: (405) 22 and 25
- ✖ L34: (258) 22 and 26
- ✖ L35: (151) 22 and 27
- ✖ L36: (113) 22 and 28
- ✖ L40: (104) 12 and 29
- ✖ L41: (67) 12 and 30
- ✖ L42: (56) (ABEDIFARD near2 EBRAHIM).In.

Failed

Search List Browse Search Draw

DB: US-PGPUB;USPAT;EPO;JPO;DERWENT;IBM\_108

☒ Details

Default operator: OR

☒ Highlight all hit items initially

BRS form ISLR form Image Text HTML

	U		Inventor	Document ID	Issue Date	Pages	Title	Current OR	Current XRef	Retrieval Cl	S	C	P				Im
1	<input type="checkbox"/>	<input type="checkbox"/>	Jun; Dong S. et al.	US 5412331 A	19950602	14	Word line driving circuit of a semiconductor memory device	326/105	326/121; 326/83;		<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US
2	<input type="checkbox"/>	<input type="checkbox"/>	Jeong; Jae-Hong	US 5862098 A	19990419	13	Word line driver circuit for semiconductor memory device	365/230.06	365/230.03		<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US
3	<input type="checkbox"/>	<input type="checkbox"/>	Kohno; Fumihiro	US 6044035 A	20000328	31	Semiconductor memory device having level-shifted precharge	365/230.06	365/189.09; 365/189.11		<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US
4	<input type="checkbox"/>	<input type="checkbox"/>	Kohno; Fumihiro	US 6638955 B2	20030325	17	Semiconductor integrated circuit for which high voltage c	365/230.06	326/105		<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US

Hits Details HTML

Ready

NUM